





Texas Instruments

CD4051B-Q1, CD4053B-Q1 SCHS354C – AUGUST 1998 – REVISED MARCH 2023

CD405xB-Q1 Automotive CMOS Single 8-Channel Analog Multiplexer or Demultiplexer with Logic-Level Conversion

1 Features

- AEC-Q100 qualified for automotive applications:
 Temperature grade 1: -45°C to +125°C, T_A
- Wide range of digital and analog signal levels:
 - Digital: 3 V to 20 V
 - Analog: ≤ 20 V_{P-P}
- Low ON resistance, 125 Ω (typical) over 15 V_{P-P} signal input range for V_{DD} V_{EE} = 18 V
- High OFF resistance, channel leakage of ±100 pA (typical) at V_{DD} – V_{EE} = 18 V
- Logic-level conversion for digital addressing signals of 3 V to 20 V ($V_{DD} V_{SS} = 3$ V to 20 V) to switch analog signals to 20 V_{P-P} ($V_{DD} V_{EE} = 20$ V) matched switch characteristics, $r_{ON} = 5 \Omega$ (typical) for $V_{DD} V_{EE} = 15$ V very low quiescent power dissipation under all digital-control input and supply conditions, 0.2 μ W (typical) at
- $V_{DD} V_{SS} = V_{DD} V_{EE} = 10 V$
- Binary address decoding on chip
 S // 40 // and 45 // name atria not
- 5 V, 10 V, and 15 V parametric ratings
- 100% tested for quiescent current at 20 V
- Maximum input current of 1 µA at 18 V over full package temperature range, 100 nA at 18 V and 25°C
- Break-before-make switching eliminates channel overlap

2 Applications

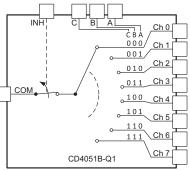
- · Analog and digital multiplexing and demultiplexing
- Analog to digital and digital to analog conversion
- Signal gating
- Factory automation
- Televisions
- Appliances
- Consumer audio
- Programmable logic circuits
- Sensors

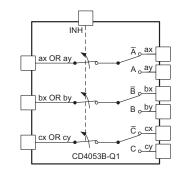
3 Description

The CD405xB-Q1 analog multiplexers and demultiplexers are digitally-controlled analog switches having low ON impedance and very low OFF leakage current. These multiplexer circuits dissipate extremely low quiescent power over the full $V_{DD} - V_{SS}$ and $V_{DD} - V_{EE}$ supply-voltage ranges, independent of the logic state of the control signals.

PART NUMBER	PACKAGE	BODY SIZE (NOM)
CD405xB-Q1	D (SOIC, 16)	9.90 mm × 3.91 mm
J403XB-Q1	PW (TSSOP, 16)	5.00 mm × 4.40 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.





Functional Diagrams of CD405xB-Q1



Table of Contents

1 Features	1
2 Applications	1
3 Description	1
4 Revision History	2
5 Pin Configuration and Functions	3
6 Specifications	5
6.1 Absolute Maximum Ratings	5
6.2 ESD Ratings	5
6.3 Recommended Operating Conditions	
6.4 Thermal Information	6
6.5 Electrical Characteristics - CD4051B-Q1	7
6.6 AC Performance Characteristics - CD4051B-Q11	1
6.7 Electrical Characteristics - CD4053B-Q11	2
6.8 AC Performance Characteristics - CD4053B-Q11	
6.9 Typical Characteristics1	7
7 Parameter Measurement Information1	8
8 Detailed Description2	1
8.1 Overview2	1

8.2 Functional Block Diagrams	. 22
8.3 Feature Description	
8.4 Device Functional Modes	
9 Application and Implementation	.25
9.1 Application Information	. 25
9.2 Typical Application	
9.3 Power Supply Recommendations	
9.4 Layout	. 26
10 Device and Documentation Support	
10.1 Documentation Support	. 28
10.2 Receiving Notification of Documentation Updates.	.28
10.3 Support Resources	. 28
10.4 Trademarks	
10.5 Electrostatic Discharge Caution	
10.6 Glossary	.28
11 Mechanical, Packaging, and Orderable	
Information	. 28

4 Revision History

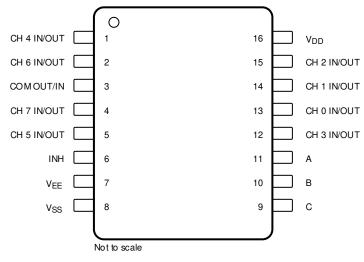
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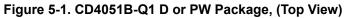
С	hanges from Revision B (April 2019) to Revision C (March 2023)	Page
•	Updated the numbering format for tables, figures, and cross-references throughout the document	1
•	Updated CD4051-Q1 specifications throughout the data sheet	1
- -	banges from Povision A (January 2008) to Povision B (April 2019)	Dago

CI	nanges from Revision A (January 2008) to Revision B (April 2019)	Page
•	Added Pin Configuration and Functions section, ESD Ratings table, Feature Description section, Device	,
	Functional Modes, Application and Implementation section, Power Supply Recommendations section, L	•
	section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Inform	ation
	section	1
•	Deleted part number CD4052B-Q1 from the data sheets	1



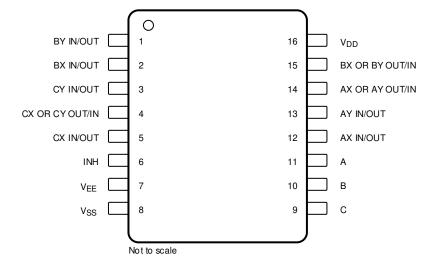
5 Pin Configuration and Functions





PIN NO. NAME		TYPE ⁽¹⁾	DESCRIPTION	
2	CH 6 IN/OUT	I/O	Channel 6 in/out	
3	COM OUT/IN	I/O	Common out/in	
4	CH 7 IN/OUT	I/O	Channel 7 in/out	
5	CH 5 IN/OUT	I/O	Channel 5 in/out	
6	INH	I	Disables all channels. See Table 8-1.	
7	V _{EE}	—	Negative power input	
8	V _{SS}	—	Ground	
9	С	I	Channel select C. See Table 8-1.	
10	В	I	Channel select B. See Table 8-1.	
11	A	I	Channel select A. See Table 8-1.	
12	CH 3 IN/OUT	I/O	Channel 3 in/out	
13	CH 0 IN/OUT	I/O	Channel 0 in/out	
14	CH 1 IN/OUT	I/O	Channel 1 in/out	
15	CH 2 IN/OUT	I/O	Channel 2 in/out	
16	V _{DD}	_	Positive power input	

(1) I = input, O = output





	PIN	TYPE ⁽¹⁾	DESCRIPTION		
NO. NAME		IIFE()	DESCRIPTION		
1	BY IN/OUT	I/O	B channel Y in/out		
2	BX IN/OUT	I/O	B channel X in/out		
3	CY IN/OUT	I/O	C channel Y in/out		
4	CX OR CY OUT/IN	I/O	C common out/in		
5	CX IN/OUT	I/O	C channel X in/out		
6	INH	I	Disables all channels. See Table 8-1.		
7	V _{EE}	_	Negative power input		
8	V _{SS}	_	Ground		
9	С	I	Channel select C. See Table 8-1.		
10	В	I	Channel select B. See Table 8-1.		
11	A	I	Channel select A. See Table 8-1.		
12	AX IN/OUT	I/O	A channel X in/out		
13	AY IN/OUT	I/O	A channel Y in/out		
14	AX OR AY OUT/IN	I/O	A common out/in		
15	BX OR BY OUT/IN	I/O	B common out/in		
16	V _{DD}	_	Positive power input		

Table 5-2	Din	Functions	CD4053B-Q1
Table 5-2.	гш	FUNCTIONS	CD4033D-QI

(1) I = input, O = output



6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾ (2)

			MIN	MAX	UNIT
		/+ to V-, Voltages Referenced to / _{SS} Terminal	-0.5	20	V
	DC Input Voltage		-0.5	V _{DD} +0.5	V
	DC Input Current A	ny One Input	-10	10	mA
T _{JMAX1}	Maximum junction temperature, ceramic package			175	°C
T _{JMAX2}	2 Maximum junction temperature, plastic package			150	°C
T _{stg}	Storage temperature		-65	150	°C

(1) Stresses beyond those listed under Absolute Maximum Rating may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Condition. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltages are with respect to ground, unless otherwise specified.

6.2 ESD Ratings

			VALUE	UNIT	
CD4051B-0	Q1				
V _(ESD)	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/ JEDEC JS-001, all pins ⁽¹⁾	±2000	V	
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾	±750	V	
CD4053B-0	Q1				
	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/ JEDEC JS-001, all pins ⁽¹⁾	±2500	- V	
V _(ESD)		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾	±1500		

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

	MIN	NOM MAX	UNIT
Temperature Range	-55	125	°C

CD4051B-Q1, CD4053B-Q1 SCHS354C – AUGUST 1998 – REVISED MARCH 2023



6.4 Thermal Information

		CD40	5xB-Q1	
	THERMAL METRIC ⁽¹⁾	D (SOIC)	PW (TSSOP)	UNIT
		16 PINS	16 PINS	
R _{θJA}	Junction-to-ambient thermal resistance	86.7	116.5	°C/W
R _{0JC(top)}	Junction-to-case (top) thermal resistance	47.3	47.2	°C/W
R _{θJB}	Junction-to-board thermal resistance	45.3	63.0	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	12.1	6.4	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	44.9	62.1	°C/W
R _{0JC(bot)}	Junction-to-case (bottom) thermal resistance	N/A	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.



6.5 Electrical Characteristics - CD4051B-Q1

Over operating free-air temperature range, $V_{SUPPLY} = \pm 5 V$, and $R_L = 100 \Omega$, (unless otherwise noted)⁽¹⁾

PARAMETER		Т	EST CONDI	TIONS		MIN TYP	MAX	UNIT
	V _{IS} (V)	V _{EE} (V)	V _{SS} (V)	V _{DD} (V)	TEMP			
SIGNAL INPUTS (VIS) AND OUTPUTS (VO		B-Q1						
					–55°C		60	
					–40°C		60	
		0 V	0 V	5 V	25°C	17	60	
					85°C		150	
					125°C		150	
					–55°C		60	
					–40°C		60	
		0 V	0 V	10 V	25°C	18	60	
					85°C		300	
Quiescent Device Current, I _{DD} (Max)					125°C		300	
					–55°C		60	μA
					–40°C		60	
		0 V	0 V	15 V	25°C	18	60	
					85°C		600	
					125°C		600	
					–55°C		100	
					–40°C		100	
		0 V	0 V	20 V	25°C	18	100	
					85°C		3000	
					125°C		3000	
					–55°C		800	
			0 V	5 V	–40°C		850	
		0 V			25°C	470	1050	
					85°C		1200	
					125°C		1300	
					–55°C		310	
					–40°C		300	
Drain to Source ON Resistance r_{ON} (Max)) $\leq V_{IS} \leq V_{DD}$		0 V	0 V	10 V	25°C	180	400	Ω
					85°C		520	
					125°C		550	
					–55°C		200	
					–40°C		210	
		0 V	0	15 V	25°C	125	240	
					85°C		300	
					125°C		300	
Change in ON Resistance		0 V	0 V	5 V		15		
Between Any Two Channels),		0 V	0 V	10 V	25°C	10		Ω
AR _{ON}		0 V	0 V	15 V		5		



6.5 Electrical Characteristics - CD4051B-Q1 (continued)

Over operating free-air temperature range, $V_{SUPPLY} = \pm 5 \text{ V}$, and $R_L = 100 \Omega$, (unless otherwise noted)⁽¹⁾

	PARAMETER			TEST CONDITIONS				MIN TYP MAX	UNIT	
			V _{IS} (V)	V _{EE} (V)	V _{SS} (V)	V _{DD} (V)	TEMP			
							–55°C	± 10	C	
							-40°C			
Channel OFF		2		0 V	0 V 0 V	0 V 18 V	25°C	0.3 100 ⁽²	± 2) nA	
or ALL Chanr (Max)	ALL Channels OFF (COMMON OUT/IN) ix)							85°C	100 (;	
							125°C			
	_eakage Current:	Any Channel	5 or 0	–5 V	0 V	10.5 V	85°C	± 80	D C	
ON (Max) or ALL Channels (Max)	S ON (COMMON	OUT/IN)	5	0 V	0 V	18 V	85°C	± 80	nA	
	Input, C _{IS}							5		
Capacitance	Output, C _{OS}	CD4051-Q1		0 V	0 V	10 V	25°C	30	pF	
	Feed-through, C	IOS						0.2		
				R _L = 200	kΩ	5 V		30 6	C	
Prop Delay			V _{DD}	C _L = 50 p	F	10 V	25°C	15 3	0 ns	
				t _r , t _f = 20 i	ns	15 V		10 2	D C	



6.5 Electrical Characteristics - CD4051B-Q1 (continued)

Over operating free-air temperature range, $V_{SUPPLY} = \pm 5 V$, and $R_L = 100 \Omega$, (unless otherwise noted)⁽¹⁾

	PARAMETER			EST CONDI			MIN TYP	MAX	UNIT
		V _{IS} (V)	V _{EE} (V)	V _{SS} (V)	V _{DD} (V)	TEMP			
CONTROL (A	ADDRESS OR INHIBIT), V _C - C	D4051B-Q1							
						–55°C	0.8		
						–40°C	0.8		
					5 V	25°C		0.8	
						85°C	0.8		
						125°C	0.8		
						–55°C	0.8		
						–40°C	0.8		
nput Low Vo	ltage, V _{IL} , (Max)				10 V	25°C		0.8	V
						85°C	0.8		
						125°C	0.8		
						–55°C	0.8		
						-40°C	0.8		
					15 V	25°C		0.8	
						85°C	0.8		
						125°C	0.8		
		_				–55°C	3.5		
						–40°C	3.5		
					5 V	25°C	3.5		
						85°C	3.5		
						125°C	3.5		
						–55°C	7		
						-40°C	7		
nput High Va	ltage, V _{IH} , (Min)				10 V	25°C	7		V
	,					85°C	7		
						125°C	7		
						–55°C	11		
						–40°C	11		
					15 V	25°C	11		
						85°C	11		
						125°C	11		
			1			–55°C		±1	
						-40°C		±1	
nput current,	I _{IN} (Max)	V _{IN} = 0, 18			18 V	25°C	±0.6	±1	μA
						85°C		±1	
						125°C		±1	
			0 V	0 V	5 V		450	720	
Propagation	Address-to-Signal OUT (Channels ON	t _r , t _f = 20ns,		0 V	10 V		160	320	
Delay Time	or OFF) (See Figure 7-2	C _L = 50 pF,	0 V	0 V	15 V		120	240	ns
-	Figure 7-3, and Figure 7-8)	R _L = 10 kΩ	–5 V	0 V	5 V	_	225	450	



6.5 Electrical Characteristics - CD4051B-Q1 (continued)

Over operating free-air temperature range, $V_{SUPPLY} = \pm 5 V$, and $R_L = 100 \Omega$, (unless otherwise noted)⁽¹⁾

	PARAMETER		TE	ST CONDI	TIONS		MIN TYP	MAX	UNIT
		V _{IS} (V)	V _{EE} (V)	V _{SS} (V)	V _{DD} (V)	TEMP			
		t _r , t _f = 20	0 V	0 V	5 V		400	720	
Propagation	Inhibit-to-Signal OUT	ns,	0 V	0 V	10 V		160	320	
Delay Time	(Channel Turning ON) (See Figure 7-3)	$C_{L} = 50 \text{ pF},$	0 V	0 V	15 V		120	240	ns
		R _L = 1 kΩ	–10 V	0 V	5 V		200	400	
		+ + - 20	0 V	0 V	5 V		200	450	
Propagation		t _r , t _f = 20 ns,	0 V	0 V	10 V		90	210	
Delay Time	(Channel Turning OFF) (See Figure 7-10)	$C_{L} = 50 \text{ pF},$	0 V	0 V	15 V		70	160	ns
		R _L = 10 kΩ	–10 V	0 V	5 V		130	300	
Input Capacita	nput Capacitance, C _{IN} (Any Address or Inhibit Input)		–5 V	0 V	5 V	25°C	5	7.5	pF

(1)

Peak-to-Peak voltage symmetrical about $(V_{DD} - V_{EE}) / 2$. Determined by minimum feasible leakage measurement for automatic testing. (2)



6.6 AC Performance Characteristics - CD4051B-Q1

 V_{DD} = +15 V, V_{SS} = V_{EE} = 0 V, T_A = 25°C (unless otherwise noted)

PARAMETER			TEST	CONDITIONS		TYP	UNIT
	V _{IS} (V)	V _{DD} (V)	R _L (kΩ)				
Cutoff (-3 dB)	5 ⁽¹⁾	10	1	V _{OS} at Common OUT/IN	CD4051-Q1	20	
Frequency Channel ON (Sine Wave Input)	V _{EE} = V _{SS} , 20Log(V _{OS} /V	_{IS}) = –3 dB		V _{OS} at Any Channel		60	MHz
	2 ⁽¹⁾	5	10			0.3%	
Total Harmonic	3 ⁽¹⁾	10	10			0.2%	%
Distortion, THD	5 ⁽¹⁾	15	10			0.12%	%
	V_{EE} = V_{SS} , f_{IS}	s = 1 kHz Sine	Wave				
-40 dB Feed-through	5 ⁽¹⁾	10	1	V _{OS} at Common OUT/IN	CD4051-Q1	12	MHz
Frequency (All Channels OFF)	V _{EE} = V _{SS} , 20Log(V _{OS} /V	_{IS}) = –40 dB		V _{OS} at Any Channel		8	MHz
–40 dB Signal Crosstalk Frequency	5(1)	10	1			3	MHz
Address-or-Inhibit-to-		10	10 ⁽²⁾			65	mV_{PEAK}
Signal Crosstalk	V_{EE} = 0, V_{SS} V_{CC} = V_{DD} -	= 0, t _r , t _f = 20 V _{SS} (Square V	ns, mVPEAK Vave)			65	$\mathrm{mV}_{\mathrm{PEAK}}$



6.7 Electrical Characteristics - CD4053B-Q1

Over operating free-air temperature range, $V_{SUPPLY} = \pm 5 V$, and $R_L = 100 \Omega$, (unless otherwise noted)⁽¹⁾

PARAMETER						MIN TYP	MAX	UNI
	V _{IS} (V)	V _{EE} (V)	V _{SS} (V)	V _{DD} (V)	TEMP			
SIGNAL INPUTS (V _{IS}) AND OUTPUTS (V _{OS}	s) - CDIP, P	DIP, SOIC ar	nd SOP Pac	kages				
					–55°C		5	
					–40°C		5	
		0 V	0 V	5 V	25°C	0.04	5	
					85°C		150	
					125°C		150	
					–55°C		10	
					–40°C		10	
		0 V	0 V	10 V	25°C	0.04	10	
					85°C		300	
Quiescent Device Current, I _{DD} (Max)					125°C		300	
					–55°C		20	μA
					–40°C		20	
		0 V	0 V	15 V	25°C	0.04	20	
					85°C		600	
					125°C		600	1
					–55°C		100	
					–40°C		100	
		0 V	0 V	20 V	25°C	18	100	
					85°C		3000	
					125°C		3000	
					–55°C		800	
			0 V	5 V	–40°C		850	
		0 V			25°C	470	1050	
					85°C		1200	
					125°C		1300	
					–55°C		310	
					–40°C		300	
Drain to Source ON Resistance r _{ON} (Max)) ≤ V _{IS} ≤ V _{DD}		0 V	0 V	10 V	25°C	180	400	Ω
$v = v_{1S} = v_{DD}$					85°C		520	
					125°C		550	
					–55°C		200	
					-40°C		210	
		0 V	0	15 V	25°C	125	240	
					85°C		300	
					125°C		300	
Change in ON Resistance		0 V	0 V	5 V		15		
Between Any Two Channels),		0 V	0 V	10 V	25°C	10		Ω
ΔR _{ON}		0 V	0 V	15 V		5		



6.7 Electrical Characteristics - CD4053B-Q1 (continued)

Over operating free-air temperature range, $V_{SUPPLY} = \pm 5 V$, and $R_L = 100 \Omega$, (unless otherwise noted)⁽¹⁾

	PARAMETER			TE	EST CONDI	TIONS		MIN TYP MAX	UNIT
			V _{IS} (V)	V _{EE} (V)	V _{SS} (V)	V _{DD} (V)	TEMP		
							–55°C	± 100	
							–40°C		
Channel OFF		2		0 V	0 V	18 V	25°C	± ± 0.01 100 ⁽²⁾	nA
or ALL Chanr (Max)	ALL Channels OFF (COMMON OUT/IN) ax)						85°C	± 1000 (2)	
							125°C		
	Leakage Current	: Any Channel	5 or 0	–5 V	0 V	10.5 V	85°C	± 300	
ON (Max) or ALL Channels (Max)	s ON (COMMON	I OUT/IN)	5	0 V	0 V	18 V	85°C	± 300	nA
	Input, C _{IS}							5	
Capacitance	Output, C _{OS}	CD4053-Q1		0 V	0 V	10 V	25°C	9	pF
	Feed-through,	C _{IOS}						0.2	
				R _L = 200	kΩ	5 V		30 60	
Prop Delay	pp Delay	V _{DD}	C _L = 50 pF		10 V	25°C	15 30	ns	
			t _r , t _f = 20 i	าร	15 V		10 20		



6.7 Electrical Characteristics - CD4053B-Q1 (continued)

Over operating free-air temperature range, $V_{SUPPLY} = \pm 5 \text{ V}$, and $R_L = 100 \Omega$, (unless otherwise noted)⁽¹⁾

	PARAMETER						MIN TYP	MAX	UNIT
		V _{IS} (V)	V _{EE} (V)	V _{SS} (V)	V _{DD} (V)	TEMP			
CONTROL (A	ADDRESS OR INHIBIT), V_{C} - (CDIP, PDIP, SC	DIC and SO	OP Package	s				
						–55°C	1.5		
						–40°C	1.5		
					5 V	25°C		1.5	
						85°C	1.5		
						125°C	1.5		
						–55°C	3		
						-40°C	3		
nput Low Vol	ltage, V _{IL} , (Max)				10 V	25°C		3	V
						85°C	3		
						125°C	3		
						–55°C	4		
						-40°C	4		
					15 V	25°C		4	
						85°C	4		
						125°C	4		
		_				–55°C	3.5		
						-40°C	3.5		
					5 V	25°C	3.5		v
						85°C	3.5		
						125°C	3.5		
						–55°C	7		
						-40°C	7		
nnut Hiah Vo	oltage, V _{IH} , (Min)				10 V	25°C	7		
input ngn vo					10 0	20°C	7		
						125°C	7		
						–55°C	11		
						-40°C	11		
					15 V	_40 C 25°C	11		
					15 V	25 C 85°C	11		
						125°C	11		
							11		
						–55°C	0.1		
						–40°C	± 0.1		
Input current,	I _{IN} (Max)	V _{IN} = 0, 18			18 V	25°C	±10 ⁻ 5	± 0.1	μA
						85°C	±1		
						125°C	± 1		
			0 V	0 V	5 V		450	720	
Propagation	Address-to-Signal OUT (Channels ON	t _r , t _f = 20ns,		0 V	10 V		160	320	
Delay Time	or OFF) (See Figure 7-2	C _L = 50 pF, R _L = 10 kΩ	0 V	0 V	15 V		120	240	ns
	Figure 7-3, and Figure 7-8)		-5 V	0 V	5 V		225	450	



6.7 Electrical Characteristics - CD4053B-Q1 (continued)

Over operating free-air temperature range, $V_{SUPPLY} = \pm 5 V$, and $R_L = 100 \Omega$, (unless otherwise noted)⁽¹⁾

	PARAMETER		TE		TIONS		MIN TYP	MAX	UNIT
		V _{IS} (V)	V _{EE} (V)	V _{SS} (V)	V _{DD} (V)	TEMP			
		t _r , t _f = 20	0 V	0 V	5 V		400	720	
Propagation	Inhibit-to-Signal OUT (Channel Turning ON) (See	ns,	0 V	0 V	10 V		160	320	n 0
Delay Time	Figure 7-3)	$C_{L} = 50 \text{ pF},$	0 V	0 V	15 V		120	240	ns
		R _L = 1 kΩ	–10 V	0 V	5 V		200	400	
		t _r , t _f = 20	0 V	0 V	5 V		200	450	
Propagation	Initibil-lo-Signal OOT	ns,	0 V	0 V	10 V		90	210	
Delay Time	(Channel Turning OFF) (See Figure 7-10)	$C_{L} = 50 \text{ pF},$	0 V	0 V	15 V		90	160	ns
		R _L = 10 kΩ	–10 V	0 V	5 V		130	300	
Input Capacit	nput Capacitance, C _{IN} (Any Address or Inhibit Input)		–5 V	0 V	5 V	25°C	5	7.5	pF

(1)

Peak-to-Peak voltage symmetrical about $(V_{DD} - V_{EE}) / 2$. Determined by minimum feasible leakage measurement for automatic testing. (2)



6.8 AC Performance Characteristics - CD4053B-Q1

V_{DD} = +15 V, V_{SS} = V_{EE} = 0 V, T_A = 25°C (unless otherwise noted)

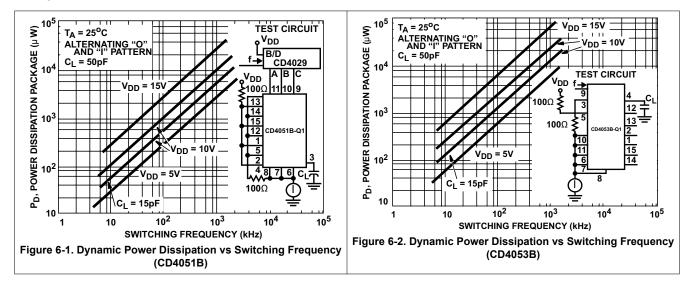
PARAMETER			TEST	CONDITIONS		ТҮР	UNIT
	V _{IS} (V)	V _{DD} (V)	R _L (kΩ)				
Cutoff (-3 dB)	5 ⁽¹⁾	10	1	V _{OS} at Common OUT/IN	CD4053-Q1	30	
Frequency Channel ON (Sine Wave Input)	V _{EE} = V _{SS} , 20Log(V _{OS} /V	_{IS}) = –3 dB		V _{OS} at Any Channel		60	MHz
	2 ⁽¹⁾	5	10			0.3%	
Total Harmonic	3 ⁽¹⁾	10	10	-		0.2%	%
Distortion, THD	5 ⁽¹⁾	15	10	-		0.12%	70
	V_{EE} = V_{SS} , f_{IS}	s = 1 kHz Sine	Wave	-			
-40 dB Feed-through	5 ⁽¹⁾	10	1	V _{OS} at Common OUT/IN	CD4053-Q1	8	MHz
Frequency (All Channels OFF)	V _{EE} = V _{SS} , 20Log(V _{OS} /V	_{IS}) = –40 dB		V _{OS} at Any Channel		8	MHz
	5 ⁽¹⁾	10	1			3	MHz
–40 dB Signal Crosstalk	V _{EE} = V _{SS} ,			Between Any Two	In Pin 2, Out Pin 14	2.5	MHz
Frequency	20Log(V _{OS} /V	_{IS}) = –3 dB		Sections, CD4053-Q1 Only	In Pin 15, Out Pin 14	6	MHz
Address-or-Inhibit-to-		10	10 ⁽²⁾			65	$\mathrm{mV}_{\mathrm{PEAK}}$
Signal Crosstalk		= 0, t _r , t _f = 20 V _{SS} (Square V	ns, mVPEAK Vave)		_	65	mV _{PEAK}

(1) Peak-to-Peak voltage symmetrical about (V_{DD} - V_{EE}) / 2.

(2) Both ends of channel.

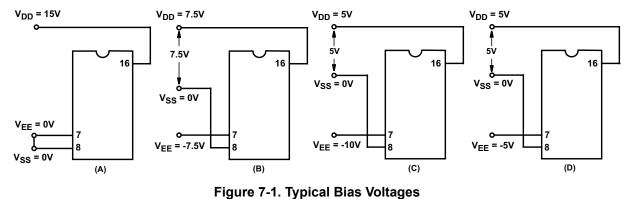


6.9 Typical Characteristics



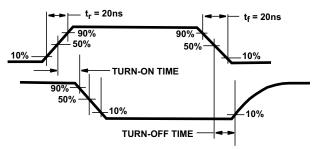


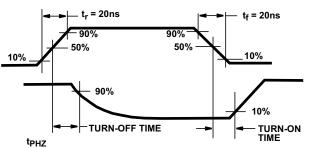
7 Parameter Measurement Information



Note

The ADDRESS (digital-control inputs) and INHIBIT logic levels are: $0 = V_{SS}$ and 1 = V_{DD} . The analog signal (through the TG) may swing from V_{EE} to V_{DD} .





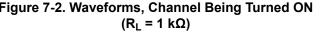


Figure 7-2. Waveforms, Channel Being Turned ON Figure 7-3. Waveforms, Channel Being Turned OFF $(R_L = 1 k\Omega)$

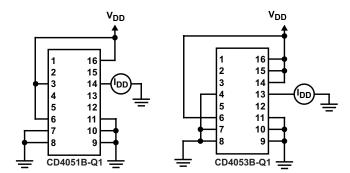


Figure 7-4. OFF Channel Leakage Current – Any Channel OFF

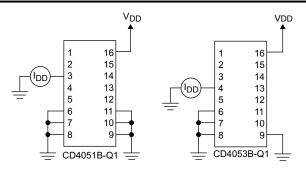


Figure 7-5. On Channel Leakage Current – Any Channel On

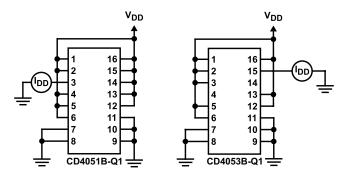


Figure 7-6. OFF Channel Leakage Current – All Channels OFF

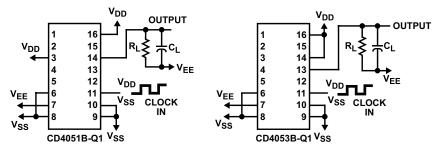


Figure 7-7. Propagation Delay – Address Input to Signal Output

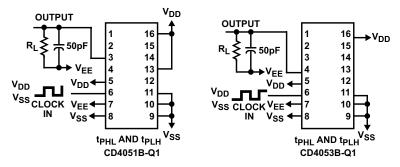
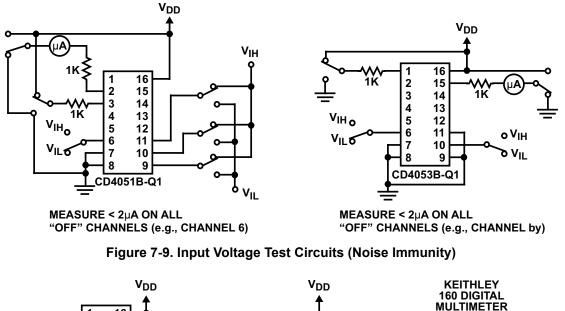
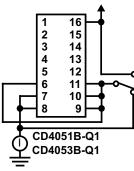


Figure 7-8. Propagation Delay – Inhibit Input to Signal Output







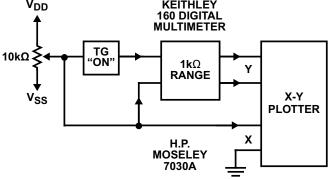
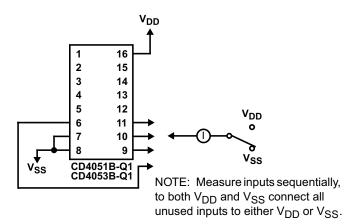
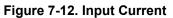
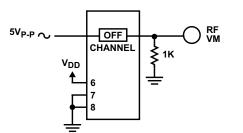


Figure 7-10. Quiescent Device Current

Figure 7-11. Channel ON Resistance Measurement Circuit







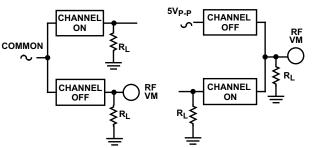
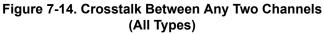


Figure 7-13. Feed-Through (All Types)





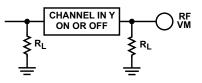


Figure 7-15. Crosstalk Between Duals or Triplets (CD4053B-Q1)

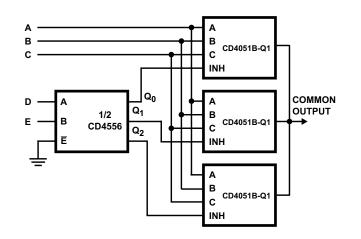


Figure 7-16. 24-to-1 MUX Addressing

8 Detailed Description

8.1 Overview

The CD4051B-Q1 and CD4053B-Q1 analog multiplexers are digitally-controlled analog switches having low ON impedance and very low OFF leakage current. Control of analog signals up to 20 V_{P-P} can be achieved by digital signal amplitudes of 4.5 V to 20 V (if V_{DD} - V_{SS} = 3 V, a V_{DD} - V_{EE} of up to 13 V can be controlled; for V_{DD} - V_{EE} level differences above 13 V, a V_{DD} - V_{SS} of at least 4.5 V is required). For example, if V_{DD} = +4.5 V, V_{SS} = 0 V, and V_{EE} = -13.5 V, analog signals from -13.5 V to +4.5 V can be controlled by digital inputs of 0 V to 5 V. These multiplexer circuits dissipate extremely low quiescent power over the full V_{DD} - V_{SS} and V_{DD} - V_{EE} supply-voltage ranges, independent of the logic state of the control signals. When a logic 1 is present at the inhibit input terminal, all channels are off.

The CD4051B-Q1 device is a single 8-channel multiplexer having three binary control inputs, A, B, and C, and an inhibit input. The three binary signals select 1 of 8 channels to be turned on, and connect one of the 8 inputs to the output.

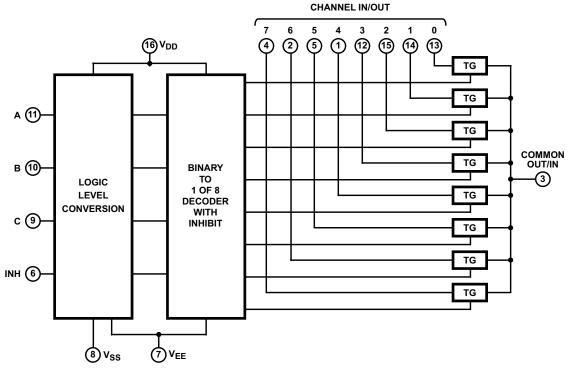
The CD4053B-Q1 device is a triple 2-channel multiplexer having three separate digital control inputs, A, B, and C, and an inhibit input. Each control input selects one of a pair of channels which are connected in a single-pole, double-throw configuration.

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When these devices are used as demultiplexers, the CHANNEL IN/OUT terminals are the outputs and the COMMON OUT/IN terminals are the inputs.

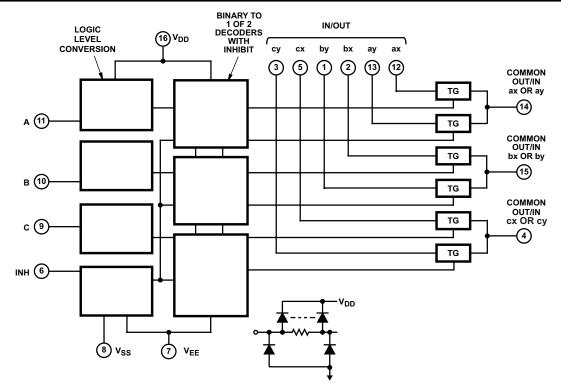
8.2 Functional Block Diagrams



All inputs are protected by standard CMOS protection network.

Figure 8-1. Functional Block Diagram, CD4051B-Q1





All inputs are protected by standard CMOS protection network.

Figure 8-2. Functional Block Diagram, CD4053B-Q1

8.3 Feature Description

The CD405xB-Q1 line of multiplexers and demultiplexers can accept a wide range of digital and analog signal levels. Digital signals range from 3 V to 20 V, and analog signals are accepted at levels \leq 20 V. The devices have low ON resistance, typically 125 Ω over 15 V_{P-P} signal input range for V_{DD} – V_{EE} = 18 V. This feature allows for very little signal loss through the switch. Matched switch characteristics are typically r_{ON} = 5 Ω for V_{DD} – V_{EE} = 15 V.

The CD405xB-Q1 devices also have high OFF resistance, which keeps from wasting power when the switch is in the OFF position, with typical channel leakage of ±100 pA at $V_{DD} - V_{EE} = 18$ V. Very low quiescent power dissipation under all digital-control input and supply conditions, typically 0.2 µW at $V_{DD} - V_{SS} = V_{DD} - V_{EE} = 10$ V keeps power consumption total very low. All devices have been 100% tested for quiescent current at 20 V with maximum input current of 1 µA at 18 V over the full package temperature range, and only 100 nA at 18 V and 25°C.

Logic-level conversion for digital addressing signals of 3 V to 20 V ($V_{DD} - V_{SS} = 3$ V to 20 V) to switch analog signals to 20 V_{P-P} ($V_{DD} - V_{EE} = 20$ V). Binary address decoding on chip makes channel selection easy. When channels are changed, a break-before-make system eliminates channel overlap.



8.4 Device Functional Modes

	Table	8-1.	Truth	Table ⁽¹⁾
--	-------	------	-------	----------------------

	IN	ON CHANNEL(S)				
INHIBIT	С	В	A	UN CHANNEL(S)		
CD4051B-Q1						
L	L	L	L	0		
L	L	L	Н	1		
L	L	Н	L	2		
L	L	Н	н	3		
L	Н	L	L	4		
L	Н	L	Н	5		
L	Н	Н	L	6		
L	Н	Н	Н	7		
н	Х	Х	Х	None		
CD4053B-Q1						
L	L	L	L	ay or by or cy		
L	Н	Н	Н	ay or by or cy		
Н	Х	Х	Х	None		

(1) X = Do not care



9 Application and Implementation

Note

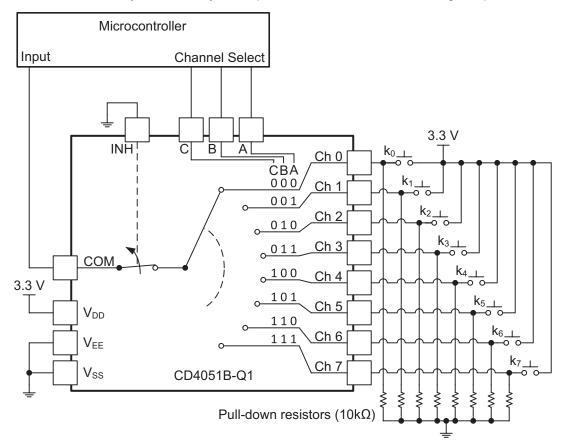
Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

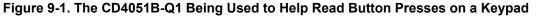
9.1 Application Information

The CD405xB-Q1 multiplexers and demultiplexers can be used for a wide variety of applications.

9.2 Typical Application

One application of the CD4051B-Q1 is to use it in conjunction with a microcontroller to poll a keypad. Figure 9-1 shows the basic schematic for such a polling system. The microcontroller uses the channel select pins to cycle through the different channels while reading the input to see if a user is pressing any of the keys. This application is a very robust setup, allowing for multiple simultaneous key-presses with very little power consumption. This setup also uses very few pins on the microcontroller. The down side of polling is that the microcontroller must continually scan the keys for a press and can do little else during this process.





9.2.1 Design Requirements

These devices use CMOS technology and have balanced output drive. Take care to avoid bus contention because it can drive currents that would exceed maximum limits. The high drive will also create fast edges into light loads, so routing and load conditions should be considered to prevent ringing.



9.2.2 Detailed Design Procedure

- 1. Recommended Input Conditions:
 - For switch time specifications, see propagation delay times in *Electrical Characteristics*.
 - Inputs should not be pushed more than 0.5 V above V_{DD} or below V_{EE}.
 - For input voltage level specifications for control inputs, see V_{IH} and V_{IL} in *Electrical Characteristics*.
- 2. Recommended Output Conditions:
 - Outputs should not be pulled above V_{DD} or below V_{EE}.
- 3. Input or output current consideration:
 - The CD405xB-Q1 series of parts do not have internal current drive circuitry and thus cannot sink or source current. Any current will be passed through the device.

9.2.3 Application Curve

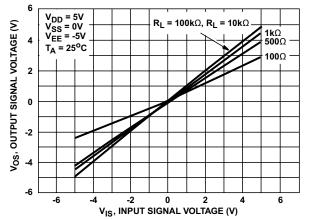


Figure 9-2. ON Characteristics for 1 of 8 Channels (CD4051B-Q1)

9.3 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Electrical Characteristics*.

Each V_{CC} terminal should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, a 0.1- μ F bypass capacitor is recommended. If there are multiple pins labeled V_{CC}, then a 0.01- μ F or 0.022- μ F capacitor is recommended for each V_{CC} because the V_{CC} pins will be tied together internally. For devices with dual supply pins operating at different voltages, for example V_{CC} and V_{DD}, a 0.1- μ F bypass capacitor is recommended for each supply pin. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. 0.1- μ F and 1- μ F capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results.

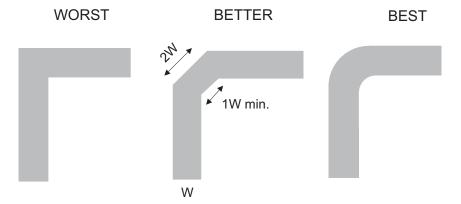
9.4 Layout

9.4.1 Layout Guidelines

Reflections and matching are closely related to loop antenna theory, but different enough to warrant their own discussion. When a PCB trace turns a corner at a 90° angle, a reflection can occur. This reflection is primarily due to the change of width of the trace. At the apex of the turn, the trace width is increased to 1.414 times its width. This upsets the transmission line characteristics, especially the distributed capacitance and self-inductance of the trace — resulting in the reflection. It is a given that not all PCB traces can be straight, and so they will have to turn corners. Figure 9-3 shows progressively better techniques of rounding corners. Only the last example maintains constant trace width and minimizes reflections.



9.4.2 Layout Example







10 Device and Documentation Support

10.1 Documentation Support

10.1.1 Related Documentation

For related documentation, see the following:

Texas Instruments, Implications of Slow or Floating CMOS Inputs

10.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

10.3 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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10.4 Trademarks

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10.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

10.6 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead finish/	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	Ball material	(3)		(4/5)	
							(6)				
CD4051BQPWRG4Q1	LIFEBUY	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	CM051BQ	
CD4051BQPWRQ1	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	CM051BQ	Samples
CD4053BQM96G4Q1	LIFEBUY	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	CD4053Q	
CD4053BQM96Q1	LIFEBUY	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	CD4053Q	

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF CD4051B-Q1, CD4053B-Q1 :

• Catalog : CD4051B, CD4053B

• Military : CD4051B-MIL, CD4053B-MIL

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

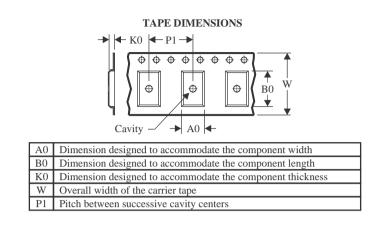


Texas

STRUMENTS

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD4051BQPWRG4Q1	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
CD4051BQPWRQ1	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



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PACKAGE MATERIALS INFORMATION

2-Feb-2023



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD4051BQPWRG4Q1	TSSOP	PW	16	2000	367.0	367.0	35.0
CD4051BQPWRQ1	TSSOP	PW	16	2000	367.0	367.0	35.0

D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



PW0016A



PACKAGE OUTLINE

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



PW0016A

EXAMPLE BOARD LAYOUT

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



PW0016A

EXAMPLE STENCIL DESIGN

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

9. Board assembly site may have different recommendations for stencil design.



^{8.} Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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